Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/722,818	KIM ET AL.	
Examiner	Art Unit	
Tuan Quach	2826	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	72, 135, 328, 329	5/24/2005	TQ
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INT	ERFERENC	CE SEARCH	ED
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